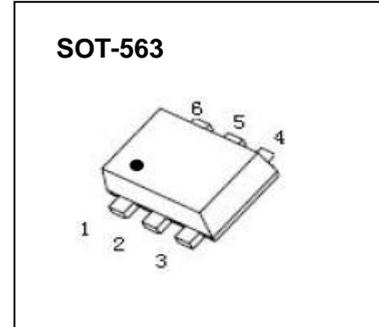


**Plastic-Encapsulate MOSFETs**

N Channel + P Channel Power MOSFET

| $V_{(BR)DSS}$ | $R_{DS(on)MAX}$ | $I_D$  |
|---------------|-----------------|--------|
| 60 V          | 5Ω@10V          | 0.34A  |
|               | 5.3Ω@4.5V       |        |
| -50V          | 8Ω@-10V         | -0.18A |
|               | 10Ω@-5V         |        |



**DESCRIPTION**

This N Channel + P Channel MOSFET has been designed using advanced power trench process to optimize the  $R_{DS(ON)}$ .

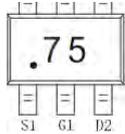
**FEATURE**

- High-Side Switching
- Low Threshold
- Fast Switching Speed

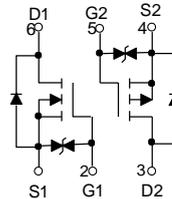
**APPLICATION**

- Drivers:Relays, Solenoids, Memories
- Battery Operated Systems
- Power Supply Converter Circuits
- Load/Power Switching Cell Phones, Pagers

**MARKING: 75**



**Equivalent Circuit**



**MAXIMUM RATINGS ( $T_a=25^\circ\text{C}$  unless otherwise noted)**

| Symbol   | Parameter   | Value    | Unit |
|--|---|----------|------|
| <b>N-Channel MOSFET</b>                                      |   |          |      |
| $V_{DS}$   | Drain-Source Voltage                                | 60       | V    |
| $V_{GS}$   | Gate-Source Voltage                                 | ±20      | V    |
| $I_D$  | Drain Current -Continuous                           | 0.34     | A    |
| $I_{DM}$   | Drain Current - Pulsed(Note1)                       | 1.36     | A    |
| <b>P- Channel MOSFET</b>                                     |   |          |      |
| $V_{DS}$   | Drain-Source Voltage                                | -50      | V    |
| $V_{GS}$   | Gate-Source Voltage                                 | ±20      | V    |
| $I_D$  | Drain Current -Continuous                           | -0.18    | A    |
| $I_{DM}$   | Drain Current – Pulsed (Note1)                      | -0.7     | A    |
| <b>Power Dissipation, Temperature and Thermal Resistance</b> |   |          |      |
| $P_D$  | Power Dissipation                                   | 0.15     | W    |
| $R_{\theta JA}$  | Thermal Resistance from Junction to Ambient (Note2) | 833      | °C/W |
| $T_j$  | Junction Temperature                                | 150      | °C   |
| $T_{stg}$  | Storage Temperature                                 | -55~+150 | °C   |
| $T_L$  | Lead Temperature                                    | 260      | °C   |



# FTK1029NP

## MOSFET ELECTRICAL CHARACTERISTICS

T<sub>a</sub>=25 °C unless otherwise specified

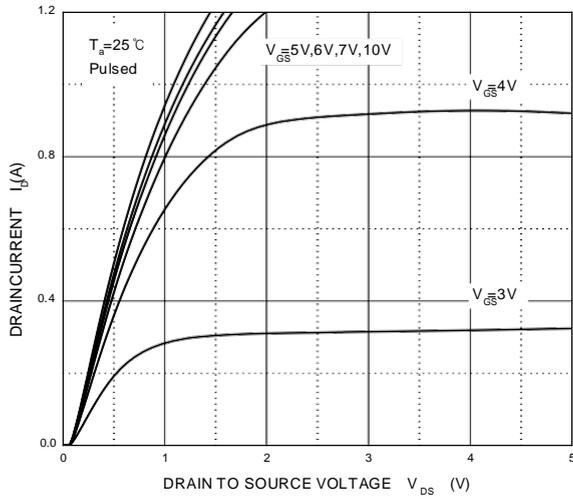
| Parameter  | Symbol               | Test conditions  | Min  | Typ   | Max   | Unit |
|--|----------------------|--|------|-------|-------|------|
| <b>N- Channel MOSFET</b>                           |                      |  |      |       |       |      |
| Drain-source breakdown voltage                     | V <sub>(BR)DSS</sub> | V <sub>GS</sub> =0V, I <sub>D</sub> =250μA                               | 60   |       |       | V    |
| Zero gate voltage drain current                    | I <sub>DSS</sub>     | V <sub>DS</sub> =48V, V <sub>GS</sub> =0V                                |      |       | 1     | μA   |
| Gate-body leakage current                          | I <sub>GSS</sub>     | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V                               |      |       | ±10   | μA   |
|  |                      | V <sub>GS</sub> =±10V, V <sub>DS</sub> =0V                               |      |       | ±200  | nA   |
|  |                      | V <sub>GS</sub> =±5V, V <sub>DS</sub> =0V                                |      |       | ±100  | nA   |
| Gate threshold voltage (note 3)                    | V <sub>GS(th)</sub>  | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =1mA                   | 1    | 1.3   | 2.5   | V    |
| Drain-source on-resistance (note 3)                | R <sub>DS(on)</sub>  | V <sub>GS</sub> =4.5V, I <sub>D</sub> =0.2A                              |      | 1.1   | 5.3   | Ω    |
|  |                      | V <sub>GS</sub> =10V, I <sub>D</sub> =0.5A                               |      | 0.9   | 5     | Ω    |
| Diode forward voltage                              | V <sub>SD</sub>      | I <sub>S</sub> =0.3A, V <sub>GS</sub> =0V                                |      |       | 1.5   | V    |
| <b>DYNAMIC PARAMETERS (note 4)</b>                 |                      |  |      |       |       |      |
| Input Capacitance                                  | C <sub>iss</sub>     | V <sub>DS</sub> =10V, V <sub>GS</sub> =0V, f=1MHz                        |      |       | 40    | pF   |
| Output Capacitance                                 | C <sub>oss</sub>     |  |      |       | 30    | pF   |
| Reverse Transfer Capacitance                       | C <sub>rss</sub>     |  |      |       | 10    | pF   |
| <b>SWITCHING PARAMETERS (note 4)</b>               |                      |  |      |       |       |      |
| Turn-on delay time                                 | t <sub>d(on)</sub>   | V <sub>GS</sub> =10V, V <sub>DD</sub> =50V,                              |      |       | 10    | ns   |
| Turn-off delay time                                | t <sub>d(off)</sub>  | R <sub>L</sub> =250Ω, R <sub>GEN</sub> =50Ω,                             |      |       | 15    | ns   |
| Reverse recovery time                              | t <sub>rr</sub>      | I <sub>S</sub> =300mA;   |      | 30    |       | ns   |
| Recovered charge                                   | Q <sub>r</sub>       | dI <sub>S</sub> /dI=-100A/s; V <sub>GS</sub> =0V;<br>V <sub>R</sub> =25V |      | 30    |       | nC   |
| <b>P- Channel MOSFET</b>                           |                      |  |      |       |       |      |
| Drain-source breakdown voltage                     | V <sub>(BR)DSS</sub> | V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA                              | -50  |       |       | V    |
| Zero gate voltage drain current                    | I <sub>DSS</sub>     | V <sub>DS</sub> =-50V, V <sub>GS</sub> =0V                               |      |       | -15   | μA   |
|  |                      | V <sub>DS</sub> =-25V, V <sub>GS</sub> =0V                               |      |       | -0.1  | μA   |
| Gate-body leakage current                          | I <sub>GSS</sub>     | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V                               |      |       | ±10   | μA   |
| Gate threshold voltage (note 3)                    | V <sub>GS(th)</sub>  | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA                | -0.9 | -1.62 | -2    | V    |
| Drain-source on-resistance (note 3)                | R <sub>DS(on)</sub>  | V <sub>GS</sub> =-5V, I <sub>D</sub> =-0.1A                              |      | 5.5   | 10    | Ω    |
|  |                      | V <sub>GS</sub> =-10V, I <sub>D</sub> =-0.1A                             |      | 4.1   | 8     | Ω    |
| Forward transconductance (note 3)                  | g <sub>FS</sub>      | V <sub>DS</sub> =-25V, I <sub>D</sub> =-0.1A                             | 0.05 |       |       | S    |
| <b>DYNAMIC CHARACTERISTICS (note 4)</b>            |                      |  |      |       |       |      |
| Input capacitance                                  | C <sub>iss</sub>     | V <sub>DS</sub> =-5V, V <sub>GS</sub> =0V, f=1MHz                        |      | 30    |       | pF   |
| Output capacitance                                 | C <sub>oss</sub>     |  |      | 10    |       | pF   |
| Reverse transfer capacitance                       | C <sub>rss</sub>     |  |      | 5     |       | pF   |
| <b>SWITCHING CHARACTERISTICS (note 4)</b>          |                      |  |      |       |       |      |
| Turn-on delay time                                 | t <sub>d(on)</sub>   | V <sub>DD</sub> =-15V,<br>R <sub>L</sub> =50Ω, I <sub>D</sub> =-2.5A     |      | 2.5   |       | ns   |
| Turn-on rise time                                  | t <sub>r</sub>       |  |      | 1     |       | ns   |
| Turn-off delay time                                | t <sub>d(off)</sub>  |  |      | 16    |       | ns   |
| Turn-off fall time                                 | t <sub>f</sub>       |  |      | 8     |       | ns   |
| <b>SOURCE-DRAIN DIODE CHARACTERISTICS (note 4)</b> |                      |  |      |       |       |      |
| Continuous Current                                 | I <sub>S</sub>       |  |      |       | -0.18 | A    |
| Pulsed Current                                     | I <sub>SM</sub>      |  |      |       | -0.7  | A    |
| Diode forward voltage (note 3)                     | V <sub>DS</sub>      | I <sub>S</sub> =-0.13A, V <sub>GS</sub> =0V                              |      |       | -2.2  | V    |

- Note:**
- 1、 Surface mounted on FR-4 board using minimum pad size, 1oz copper
  - 2、 Repetitive Rating: Pulse width limited by maximum junction temperature.
  - 3、 Pulse test: pulse width ≤300 μ s, duty cycle ≤2%
  - 4、 These parameters have no way to verify.

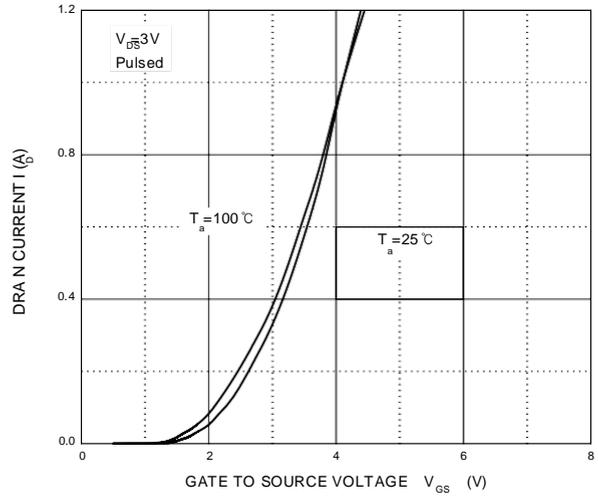
## Typical Characteristics

### N-Channel MOS

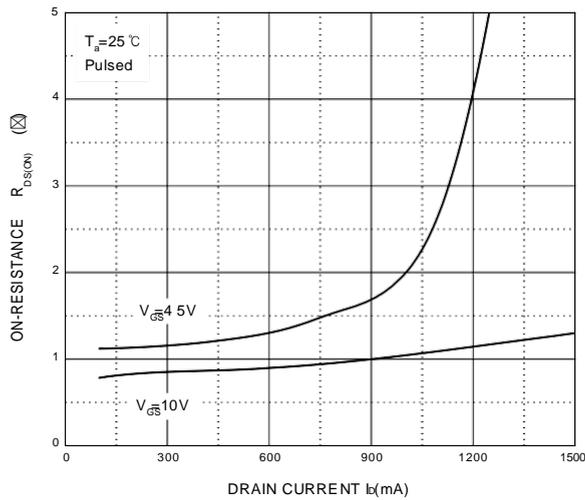
Output Characteristics



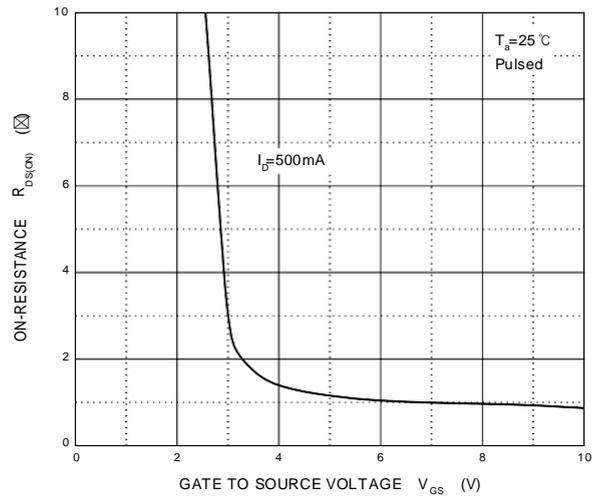
Transfer Characteristics



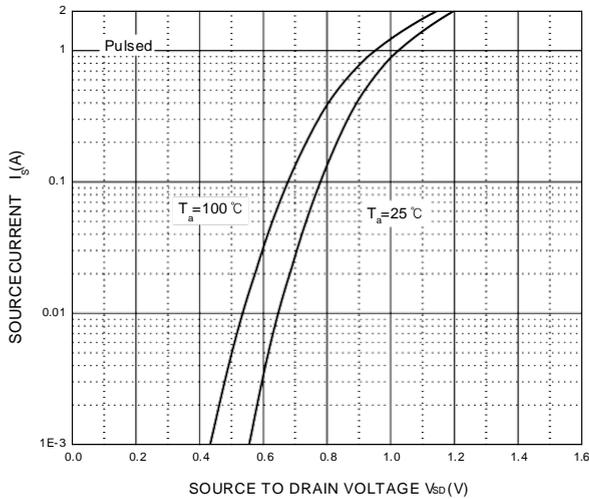
$R_{DS(ON)}$  —  $I_D$



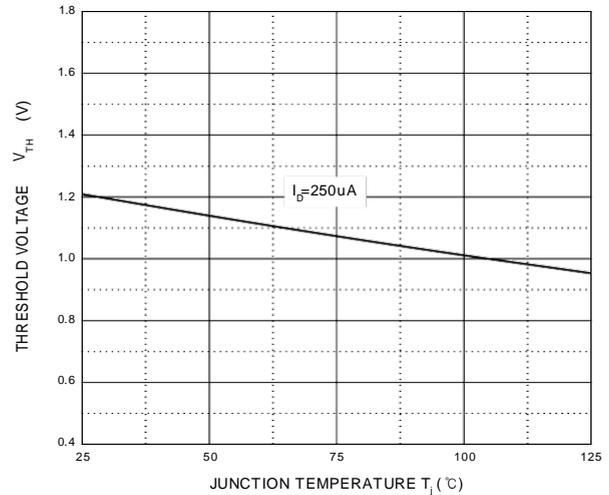
$R_{DS(ON)}$  —  $V_{GS}$



$I_S$  —  $V_{SD}$



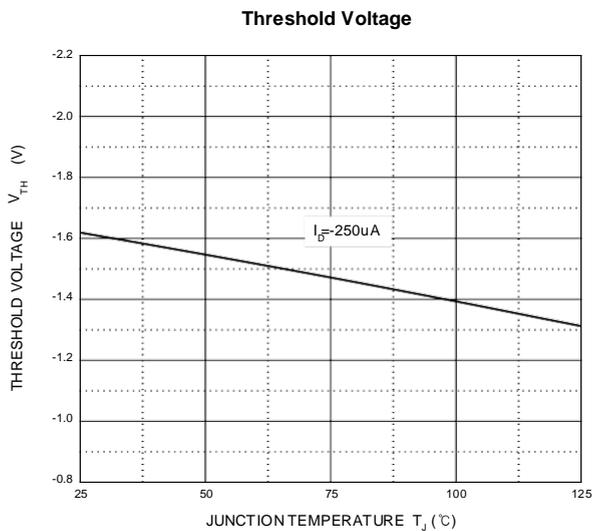
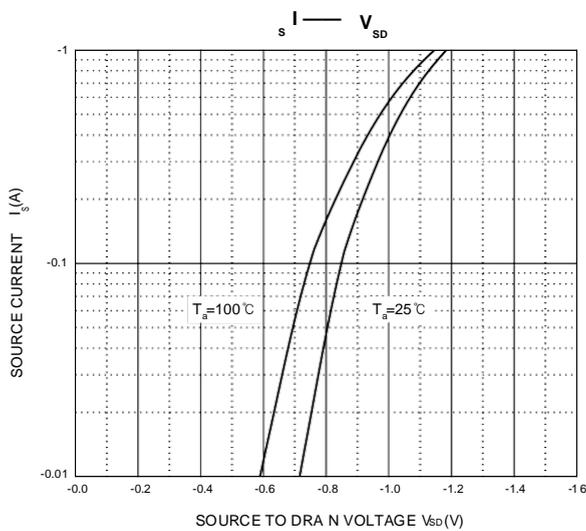
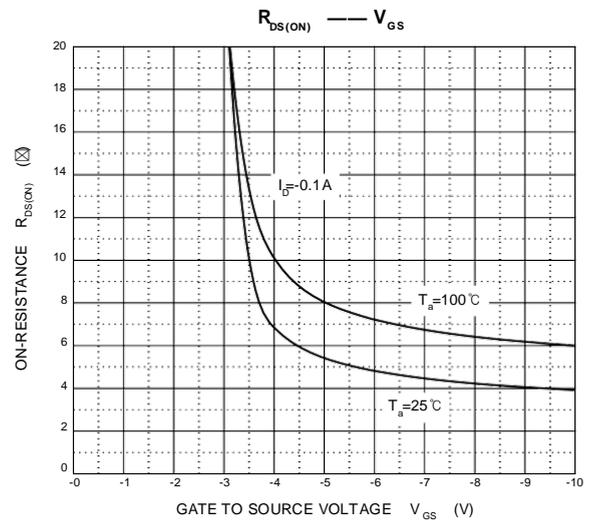
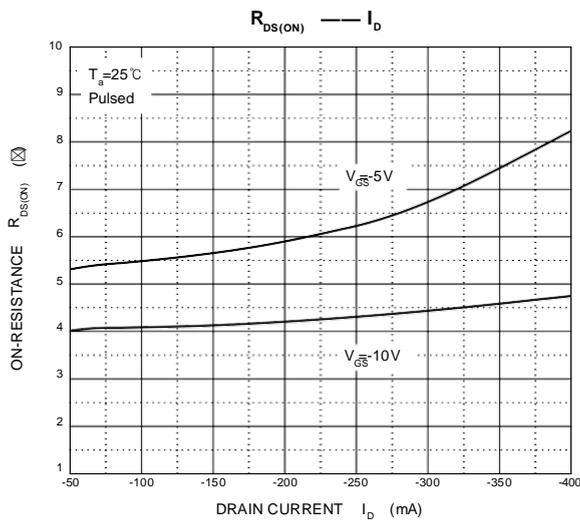
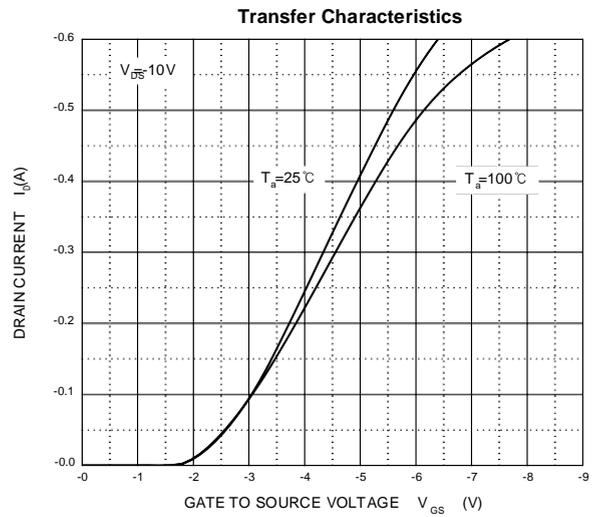
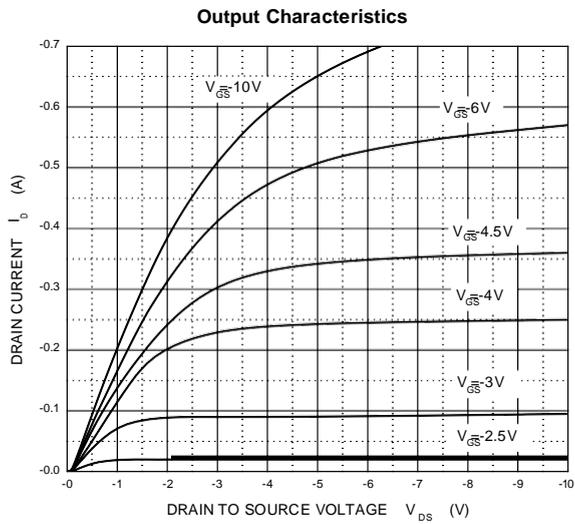
Threshold Voltage





# FTK1029NP

## Typical Characteristics P-Channel MOS





# FTK1029NP

## ne Dimensions

| Symbol   | Dimension in Millimeters |       |
|----------|--------------------------|-------|
|          | Min                      | Max   |
| A        | 0.90                     | 1.00  |
| A1       | 0.010                    | 0.100 |
| B        | 1.20                     | 1.40  |
| bp       | 0.25                     | 0.45  |
| C        | 0.09                     | 0.15  |
| D        | 2.00                     | 2.20  |
| E        | 1.15                     | 1.35  |
| HE       | 2.15                     | 2.55  |
| Lp       | 0.25                     | 0.46  |
| $\theta$ | 0°                       | 6°    |